

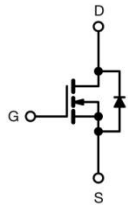


N-channel Power MOSFET

PRODUCT SUMMARY	
V_{DS} (V) at T_J max.	850
$R_{DS(on)}$ max. at 25°C (Ω)	$V_{GS}=10V$ 4.8
Q_g max. (nC)	22
Q_{gs} (nC)	3
Q_{gd} (nC)	6
Configuration	single



TO-252



Schematic diagram

Features

- $I_D=3A$ ($V_{GS}=10V$)
- Ultra Low Gate Charge
- Improved dv/dt Capability
- 100% Avalanche Tested
- RoHS compliant

Applications

- Switching Mode Power Supplies (SMPS)
- PWM Motor Controls
- DC to DC Converters
- HID Lighting
- Bridge Circuits

ORDERING INFORMATION	
Device	SPD3N80G
Device Package	TO-252
Marking	3N80G

ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ C$, unless otherwise noted)			
Parameter	Symbol	Limit	Unit
Drain to Source Voltage	V_{DSS}	800	V
Continuous Drain Current (@ $T_C=25^\circ C$)	I_D	3	A
Continuous Drain Current (@ $T_C=100^\circ C$)		1.8	A
Drain current pulsed ⁽²⁾	I_{DM}	12	A
Gate to Source Voltage	V_{GS}	30	V
Single pulsed Avalanche Energy ⁽³⁾	E_{AS}	67	mJ
Peak diode Recovery dv/dt ⁽⁴⁾	dv/dt	6	V/ns
Total power dissipation (@ $T_C=25^\circ C$)	P_D	131	W
Derating Factor above 25°C		1.05	W/°C
Operating Junction Temperature & Storage Temperature	T_{STG}, T_J	-55 to + 150	°C
Maximum lead temperature for soldering purpose	T_L	260	°C

Notes

1. Drain current is limited by maximum junction temperature.
2. Repetitive rating : pulse width limited by junction temperature.
3. $L = 15mH$, $I_{AS} = 3A$, $V_{DD} = 50V$, $R_G = 25\Omega$, Starting at $T_J = 25^\circ C$
4. $I_{SD} \leq 3A$, $di/dt = 100A/us$, $V_{DD} \leq BV_{DSS}$, Starting at $T_J = 25^\circ C$



THERMAL CHARACTERISTICS			
Parameter	Symbol	Value	Unit
Thermal resistance, Junction to case	R_{thjc}	0.95	$^{\circ}\text{C}/\text{W}$
Thermal resistance, Junction to ambient	R_{thja}	80.2	$^{\circ}\text{C}/\text{W}$

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}\text{C}$ unless otherwise specified)						
Parameter	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Off Characteristics						
Drain to source breakdown voltage	BV_{DSS}	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	800	--	--	V
Breakdown voltage temperature coefficient	$\Delta BV_{DSS} / \Delta T_J$	$I_D=250\mu\text{A}$, referenced to 25°C	--	0.42	--	$\text{V}/^{\circ}\text{C}$
Drain to source leakage current	I_{DSS}	$V_{DS}=800\text{V}, V_{GS}=0\text{V}$	--	--	1	μA
		$V_{DS}=640\text{V}, T_C=125^{\circ}\text{C}$	--	--	50	μA
Gate to source leakage current, forward	I_{GSS}	$V_{GS}=30\text{V}, V_{DS}=0\text{V}$	--	--	100	nA
Gate to source leakage current, reverse		$V_{GS}=-30\text{V}, V_{DS}=0\text{V}$	--	--	-100	nA
On Characteristics						
Gate threshold voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	2	--	4	V
Drain to source on state resistance	$R_{DS(ON)}$	$V_{GS}=10\text{V}, I_D=1.5\text{A}$	--	4	4.8	Ω
Forward Transconductance	G_{fs}	$V_{DS}=30\text{V}, I_D=1.5\text{A}$	--	3.6	--	S
Dynamic Characteristics						
Input capacitance	C_{iss}	$V_{GS}=0\text{V}, V_{DS}=25\text{V}, f=1\text{MHz}$	--	530	--	pF
Output capacitance	C_{oss}		--	62	--	
Reverse transfer capacitance	C_{rss}		--	15	--	
Turn on delay time	$t_{d(on)}$	$V_{DS}=400\text{V}, I_D=3\text{A}, R_G=25\Omega$	--	11	--	ns
Rising time	t_r		--	31	--	
Turn off delay time	$t_{d(off)}$		--	52	--	
Fall time	t_f		--	33	--	
Total gate charge	Q_g	$V_{DS}=640\text{V}, V_{GS}=10\text{V}, I_D=3\text{A}$	--	15	--	nC
Gate-source charge	Q_{gs}		--	3	--	
Gate-drain charge	Q_{gd}		--	6	--	

SOURCE TO DRAIN DIODE RATINGS CHARACTERISTICS						
Parameter	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous source current	I_S	Integral reverse p-n Junction diode in the MOSFET	--	--	3	A
Pulsed source current	I_{SM}		--	--	12	A
Diode forward voltage drop.	V_{SD}	$I_S=3\text{A}, V_{GS}=0\text{V}$	--	--	1.2	V
Reverse recovery time	T_{rr}	$I_S=3\text{A}, V_{GS}=0\text{V}$,	--	280	--	ns
Reverse recovery Charge	Q_{rr}	$di/dt=100\text{A}/\mu\text{s}$	--	1.9	--	μC



Fig1. Output characteristics

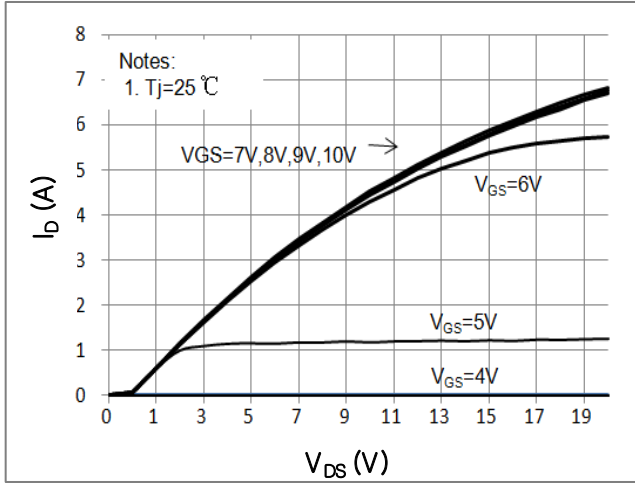


Fig2. Drain-source on-state resistance

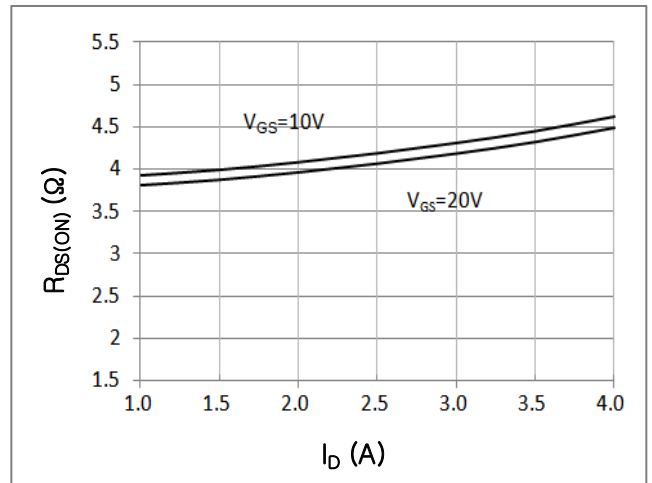


Fig3. Gate charge characteristics

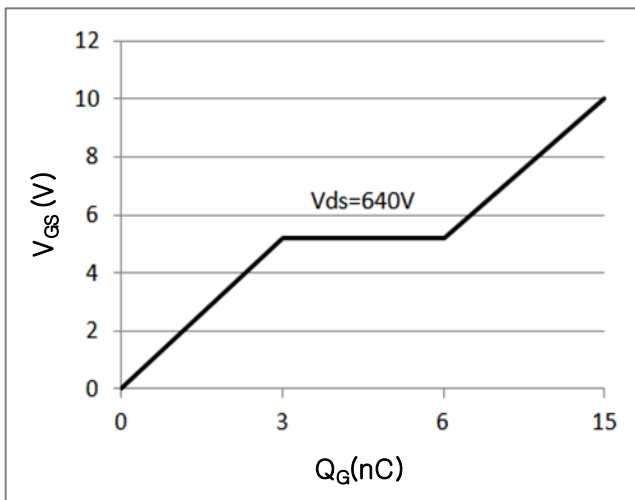


Fig 4. Capacitance Characteristics

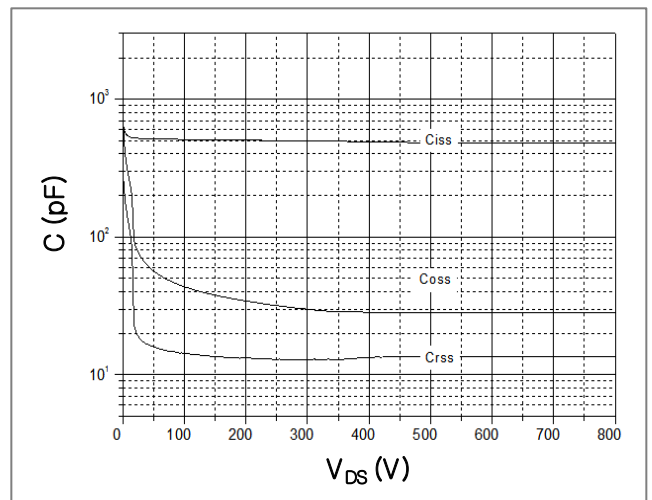


Fig 5. $R_{DS(ON)}$ vs junction temperature

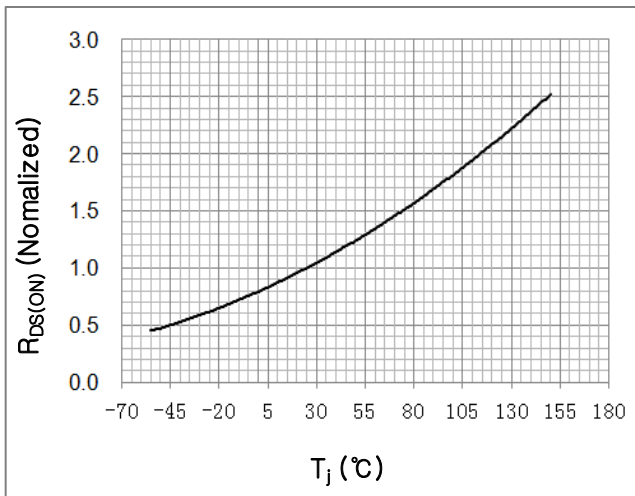


Fig 6. BV_{DSS} vs junction temperature

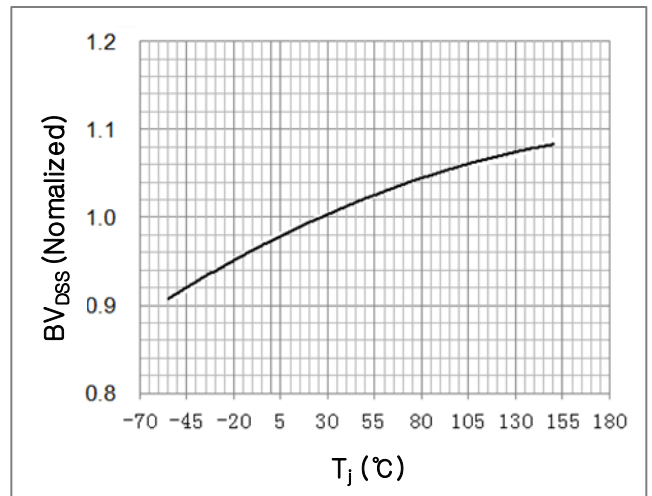


Fig 7 . Safe operating area

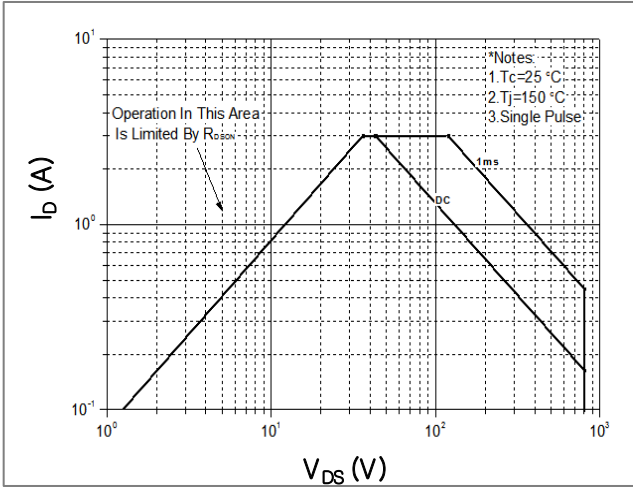


Fig 8. Transient thermal impedance

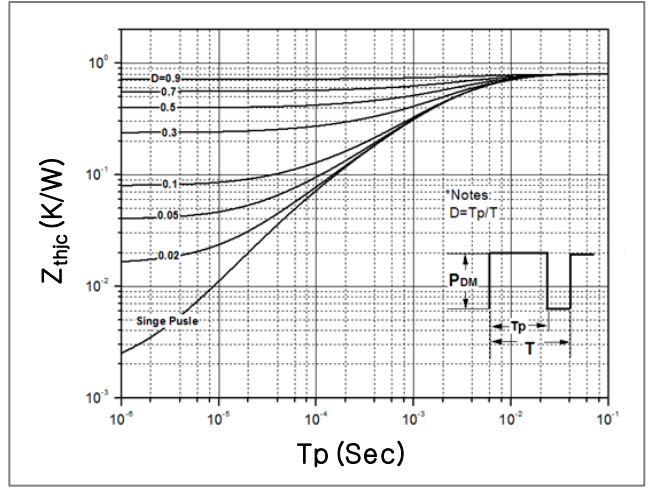


Fig 9. Forward characteristics of reverse diode

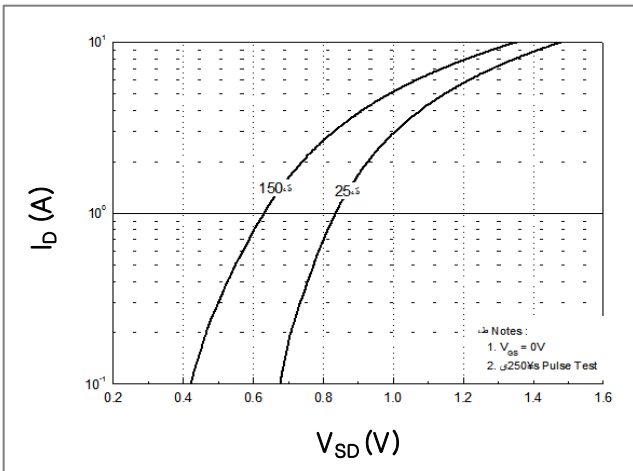


Fig 10. Gate charge test circuit & waveform

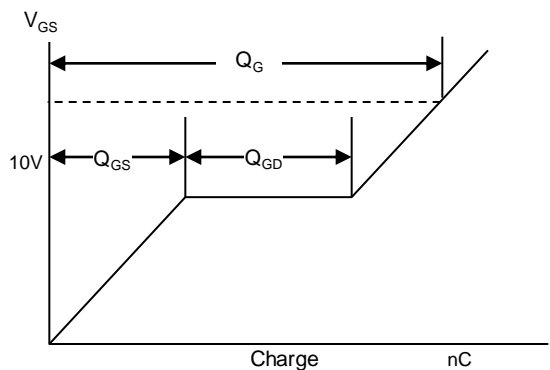
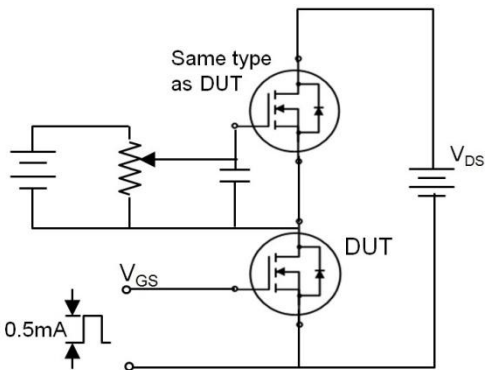


Fig 11. Switching time test circuit & waveform

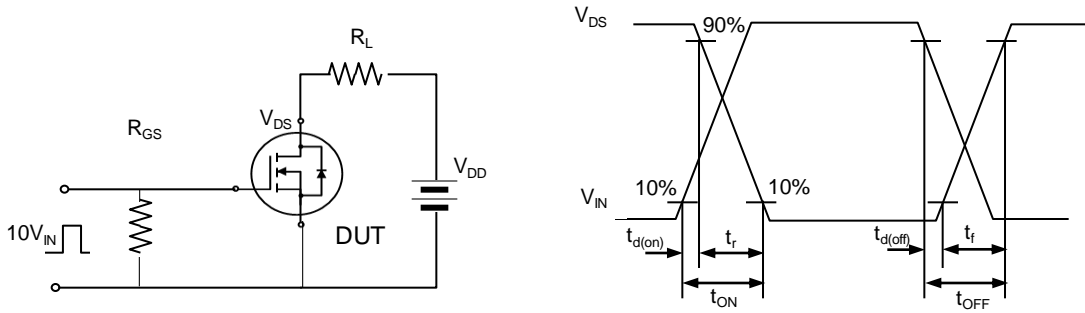


Fig 12. Unclamped Inductive switching test circuit & waveform

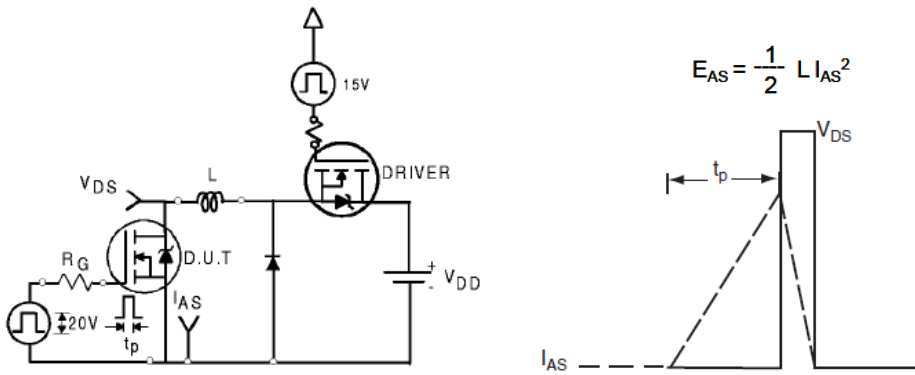
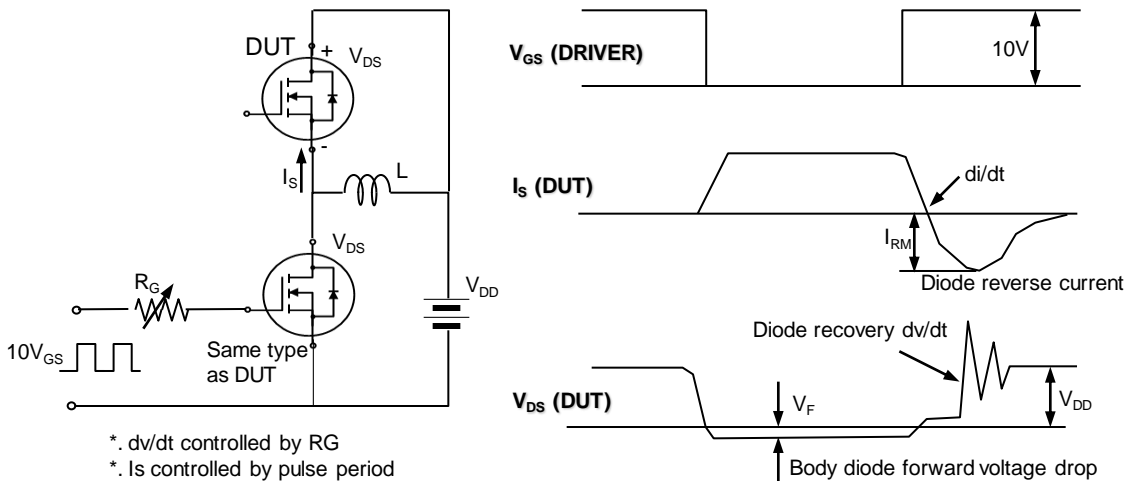


Fig 13. Peak diode recovery dv/dt test circuit & waveform





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